

**Search Notes**

Application/Control No.

10/760,060

Examiner

Nhan T. Le

Applicant(s)/Patent under  
Reexamination

JIN ET AL.

Art Unit

2618

**SEARCHED**

Class	Subclass	Date	Examiner
495	103 127.1 127.2	08/25/06	N. Le
	232.1 244.1	/	/
	245.1 250.1	/	/
	522 561	/	/
370	318,336	/	/
	327,397	/	/
395	345	✓	✓

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East search	08/25/06	N. Le

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner